

UTC UNISONIC TECHNOLOGIES CO., LTD

13N50K **Preliminary Power MOSFET**

13A, 500V N-CHANNEL POWER MOSFET

DESCRIPTION

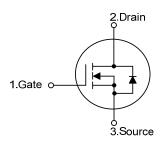
The UTC 13N50K is an N-Channel enhancement mode power MOSFET. The device adopts planar stripe and uses DMOS technology to minimize and provide lower on-state resistance and faster switching speed. It can also withstand high energy pulse under the avalanche and commutation mode conditions.

The UTC 13N50K is ideally suitable for high efficiency switch mode power supply, power factor correction, electronic lamp ballast based on half bridge topology.

FEATURES

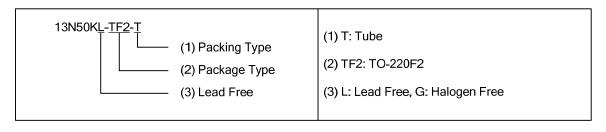
- * $R_{DS(ON)}$ <0.48 Ω @ V_{GS} = 10V
- * Ultra low gate charge (typical 39nC)
- * Low reverse transfer Capacitance (C_{RSS} = typical 20pF)
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

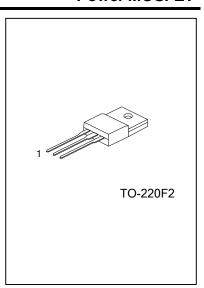
SYMBOL



ORDERING INFORMATION

Ordering Number		Deelsese	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
13N50KL-TF2-T	13N50KG-TF2-T	TO-220F2	G	D	S	Tube	





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■ MARKING INFORMATION

PACKAGE	MARKING			
TO-220F2	UTC 13N50K□ → G: Halogen Free Lot Code Data Code			

■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT	
Drain-Source Voltage	V_{DSS}	500	V	
Gate-Source Voltage	V_{GSS}	±30	V	
Continuous Drain Current	I_{D}	13	Α	
Pulsed Drain Current (Note 2)	I _{DM}	52	Α	
Avalanche Current (Note 2)	I _{AR}	13	Α	
Single Pulsed Avalanche Energy (Note 3)	E _{AS}	700	mJ	
Repetitive Avalanche Energy (Note 2)	E _{AR}	17	mJ	
Peak Diode Recovery dv/dt (Note 4)	dv/dt	4.5	V/ns	
Power Dissipation (T _C =25°C)	P_{D}	48	W	
Junction Temperature	TJ	+150	°C	
Storage Temperature	T _{STG}	-55~+150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating : Pulse width limited by maximum junction temperature
- 3. L = 8mH, I_{AS} = 13A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 4. $I_{SD} \le 13.A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θις	2.58	°C/W	

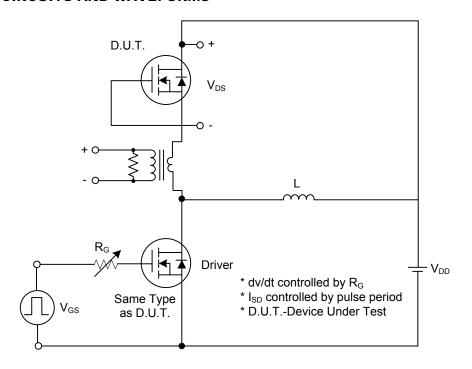
■ **ELECTRICAL CHARACTERISTICS** (T_C =25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS		TYP	MAX	UNIT	
PARAMETER SYMBOL TEST CONDITIONS MIN TYP MAX UNIT OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	$V_{GS} = 0V, I_D = 250\mu A$				V	
Drain-Source Leakage Current	I _{DSS}	V _{DS} = 500V, V _{GS} = 0V			10	μA	
	I _{GSS}	$V_{GS} = 30V, V_{DS} = 0V$			100	nA	
Gate-Source Leakage Current		$V_{GS} = -30V, V_{DS} = 0V$			-100	nA	
Breakdown Voltage Temperature Coefficient	$\triangle BV_{DSS}/\triangle T_J$	I _D =250mA,Referenced to 25°C		0.5		V/°C	
ON CHARACTERISTICS							
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V	
Static Drain-Source On-State Resistance	R _{DS(ON)}	$V_{GS} = 10V, I_D = 6.5A$		0.42	0.48	Ω	
DYNAMIC CHARACTERISTICS							
Input Capacitance	C _{ISS}	\\ -25\\ \\ -0\\		1800	2300	pF	
Output Capacitance	Coss	─V _{DS} =25V, V _{GS} =0V, ─f=1.0MHz		245	320	pF	
Reverse Transfer Capacitance	C_{RSS}			25	35	pF	
SWITCHING CHARACTERISTICS							
Turn-On Delay Time	t _{D(ON)}			40	90	nS	
Turn-On Rise Time	t_R	V_{DD} =250V, I_{D} =13A, R_{G} =25 Ω (Note 1,2)		140	290	nS	
Turn-Off Delay Time	t _{D(OFF)}			100	210	nS	
Turn-Off Fall Time	t_{F}			85	180	nS	
Total Gate Charge	Q_G	-V _{DS} =400V, I _D =13A, -V _{GS} =10 V (Note 1,2)		39	60	nC	
Gate-Source Charge	Q_GS			12		nC	
Gate-Drain Charge	Q_GD			11		nC	
DRAIN-SOURCE DIODE CHARACTERISTIC	CS AND MAXII	MUM RATINGS					
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS} = 0V, I_{S} = 13 A$			1.4	V	
Maximum Continuous Drain-Source Diode	I ₋				13	Α	
Forward Current	I _S				13	^	
Maximum Pulsed Drain-Source Diode	I _{SM}				52	Α	
Forward Current	ISM				52	^	
Reverse Recovery Time	t _{rr}	$V_{GS} = 0V, I_{S} = 13A,$		290		nS	
Reverse Recovery Charge	Q_{RR}	dI _F / dt =100A/μs (Note 1)		2.6		μC	

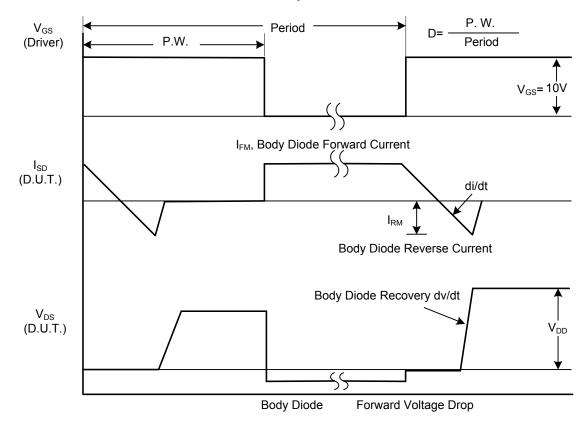
Notes: 1. Pulse Test : Pulse width≤300µs, Duty cycle≤2%

^{2.} Essentially independent of operating ambient temperature

■ TEST CIRCUITS AND WAVEFORMS

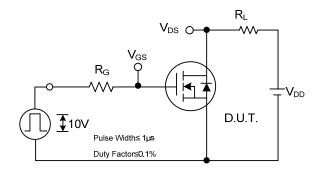


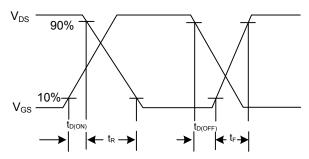
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

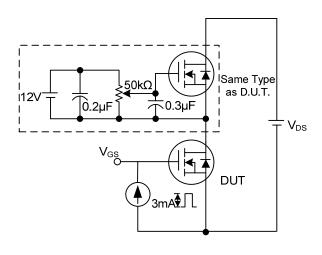
■ TEST CIRCUITS AND WAVEFORMS (Cont.)

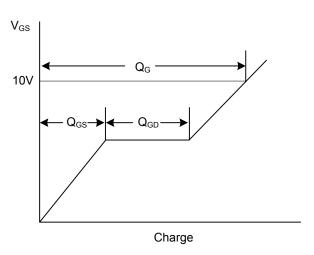




Switching Test Circuit

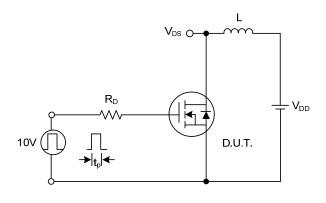
Switching Waveforms

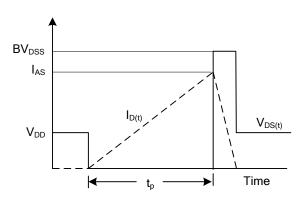




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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